Detector developments at ESRF

M. Ruat on behalf on the Detector Unit and the Instrumentation Services and Development Division

APS 3-Way Meeting, Detector Workshop, July 31st 2013



Outline

The Detector Unit at ESRF

Overview of current developments

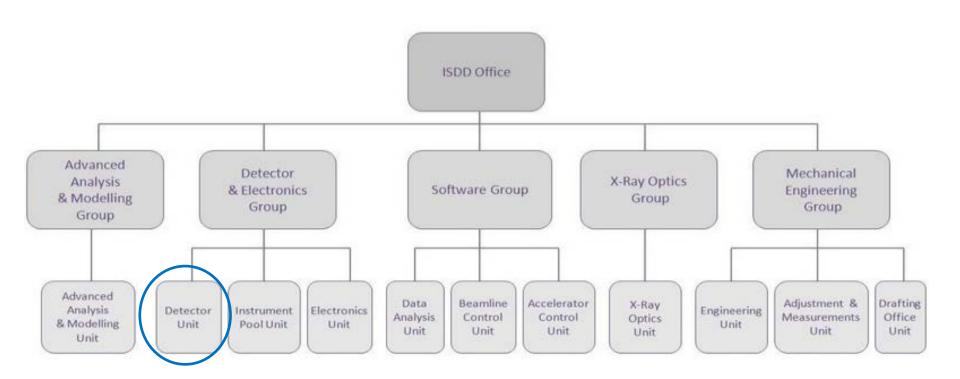
Beamlines Upgrade program (UPBL)

Warning: this is a non exhaustive and subjective presentation....



The Detector Unit at ESRF

The Detector Unit is part of the Instrument Services and Developments Division (ISDD)





The Detector Unit at ESRF

The Detector Unit is composed of:

- 9 Engineers
- 7 Technicians (Detector Technical Support Team (DTST))
- 1 visiting engineer from ALBA
- 1 PhD student
- 1 Administrative assistant

Spread into 5 laboratories

A balanced combination of:

- Services:

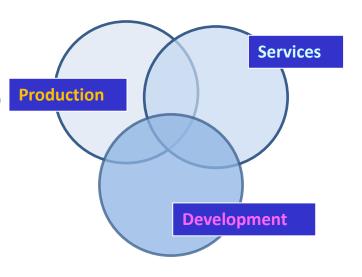
Advice, test, commissioning, loan, BL operation, administrative support (CFT, RFQ, EU project, ...)

- Instrument development:

Detectors and control electronics

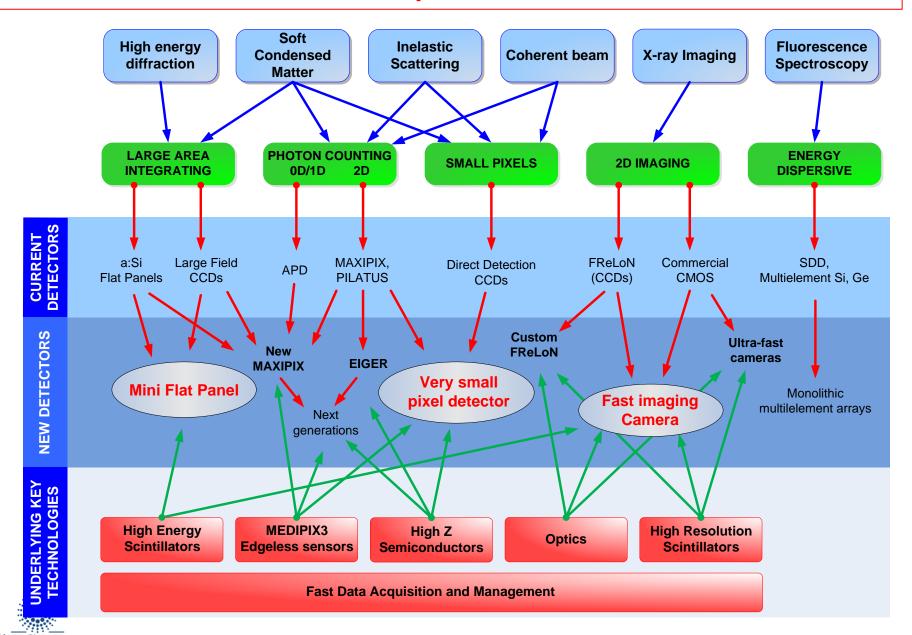
-Production

Mainly of in-house developments





Detectors @ ESRF: overall picture and foreseen evolution



The Detector Unit at ESRF

PRODUCTION

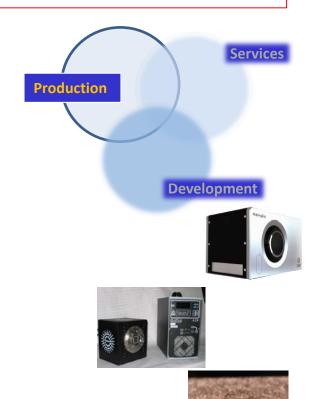
Regular **production of devices** (figures for 2012):

- Maxipix (4 systems delivered)
- FReLoN (3 cameras delivered)
- High resolution scintillators / SCF (~60 crystals produced)
- Electronic modules (MoCo, BCDU8, ...)
- A large number of customized I/O Boxes (WAGO)
- Beamviewers (focus on micro & nano beams, white beam)

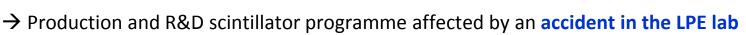
Contract for the manufacturing of 2560 IcePAP axes (over 3 years)

Sales of equipment to external labs:

- 2×2 Maxipix system (Soleil)
- 3 Monochromator controllers, MoCo (ALBA)
- 22 SCF scintillator crystals (Diamond, BNL, Australian Synchrotron, LBNL, Cornell, Max Plank, Carnegie Mellon, Korea, Bruker)





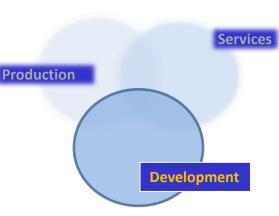




The Detector Unit at ESRF

DEVELOPMENTS: Examples of Know-How and associated projects

- Beam diagnostics
 - New Beamviewers (Diamond) & UPBLs
- OD photon counting (APD, scintillator + PMT + fast electronic)
 - ✓ XNAP Project
- Hybrid pixel detector (MAXIPIX)
 - ✓ Medipix 3 & SMARTPIX
 - ✓ Edgeless Si sensors
 - √ High-Z semiconductor sensors (HIZPAD² project)
 - ✓ PEEC (PSI-ESRF Eiger collaboration)
 - ✓ UPBLs
- X-ray Imaging (scintillator/phosphor, optical coupling)
 - ✓ Large field optical coupling
 - **✓** UPBLs
- CCD camera (FRELON)
 - ✓ UPBLs
- Spectroscopy
- Flat panel





Outline

The Detector Unit at ESRF

Overview of current developments

Beamlines Upgrade program (UPBLs)



Current developments: Beam diagnostic

White/pink beam Viewer

- pneumatic actuator
- Cooled
- pCVD diamond sensor or YAG:Ce
- Intensity monitor
- 20 μm pixel size

Monochromatic beam viewer

- pneumatic or stepper actuator
- YAG:Ce screen
- Intensity monitor
- Accessory : diode for calibration

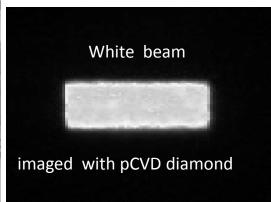
Focus beam viewer

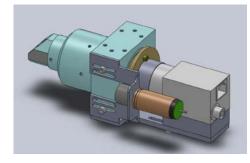
- Compact, low cost
- Standard Model: 0.8x , 1x, 2x magnification
- under development : 4x mag., 0.9 μm pixel, 3 μm resolution

Semi-transparent screen

- 450nm thick Lu₂O₃:Eu on Al₂O₃
- 8% absorption @15keV
- 1s expo @ 10¹¹ph/s/mm²
- $-\sigma=80$ nm on position















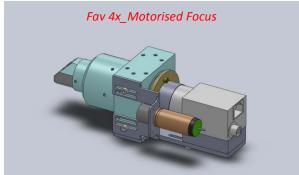


90 cameras are currently running for X-ray diagnostic

Current developments: Beam diagnostic

Focused Beam Viewer







1x version: 3.75 μ m pixel size, 10 μ m resolution 1280 x 960 pixels, 30 fps, 10bit DR In 2x2 binning \rightarrow VGA 50fps

2x version: 1.9 μm pixel size, 6 μm resolution 1280 x 960 pixels, 30fps, 10bit DR In 2x2 binning → VGA 50fps

Recently characterized:

4x version: 0.9 μ m pixel size, 3 μ m resolution 1280 x 960 pixels, 30 fps, 10bit DR In 2x2 binning \rightarrow VGA 50 fps

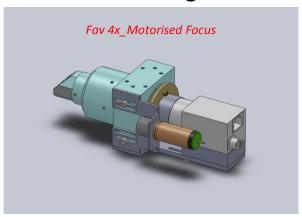
10x – 80x: sub-micrometer resolution Scientific grade camera, 5-20μm thick scintillator



Current developments: Beam diagnostic

4x magnification focused Beam Viewer: first characterization results

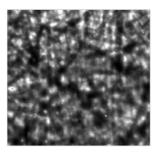
A new design



- A 90 degrees folded head with mirror
 - Integration into a small, light body
 - Need of motorized focus
 - Radiation-hard design
- 3μm spatial resolution and 0.93μm pixel size
- Robustness and reliability under evaluation

Imaging capabilities

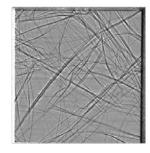
(1): Unfocused Image



(3):YAG 250μm



(2): Focus Image of foam



(4): YAG 50µm 4x magnification

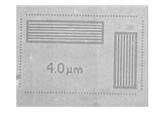


Figure 7: X-ray transmission images of a foam (1) and (2) at 15KeV X-ray energy and recorded with the basler camera coupled to different scintillators. The need of motorized focus was evaluated with real images and x-ray

patterns

C. Cruz de la Torre, T. Martin, D. Pothin, IWORID 2013



Current developments: Converter screens







Scintillators

LPE status

- PbO contamination (August 2012)
- Decontamination/ neutralization of acid (Sept 2012-Dec2012)
- Test of all equipment (Jan-Feb. 2013)
- Design of a new PbO extraction system with Safety and TID (Feb-March 2013)
- Refurbishment of lab, mainly furnace room (April-May 2013)
- Restart lab (June July 2013)
- Production: GGG:Tb , GGG:Eu, large LSO:Tb for UPBL4

Developments:

- Fast garnet scintillator: LuAG:Ce ,GGG:Ce,Cr (P.A. Douissard)
- High-stopping power material: LuAP:Tb (F. Riva)
- Large format phosphor and structured screen
- Ceramics scintillator: GLO:Eu (40µm thick)
- Structured scintillator: scintillating fiberoptic plate

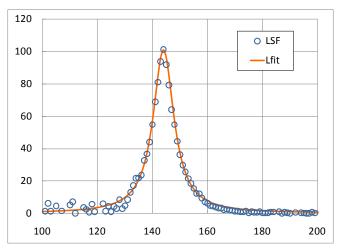


Current developments: Converter screens

New Phosphor screens

- Application: any optically coupled (lens or fibre) 2D detector with ≥ 40 mm entrance field.
- Custom development on ESRF specs :

P43 phosphor (Gd $_2$ O $_2$ S:Tb), mean grain size 2.5 μ m Active thickness from 10 μ m to 50 μ m Any area up to 200 x 270 mm 2



 $30 \ \mu m$ thick screen measured LSF FWHM = $30.8 \ \mu m$

- :-) Cost-effective, high light yield, quick implementation
- :-(Burnishing under high flux



Pixel size	2003	2011	Future
100-500nm Very high resolution	1 mag. 1 scint.		High Definition 16Mpixels
Refractive microscope			200.34
1-3μm		Custom optic	Custom optic for
High resolution Reflective microscope	Com. Ealing		enhancement of imaging contrast and speed in UV-blue band
5-30µm Medium resolution Tandem lens			Custom optic for large field of view. Dispersive EXAFS UPBL11(TEXAS)
20-50 μ m Low resolution Fiber optic input	Dem. = 3.6	Dem.= 2	FAN

for science LISIT

Pixel size	2003	2011	Future
100-500nm Very high resolution Refractive	1 mag. 1 scint.		High Definition 16Mpixels
microscope			d [2:1]
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20-50 μ m Low resolution Fiber optic input	Dem. = 3.6	Dem.= 2	FAN

for science LONI

100 mm Large-field detector for ID17/ID19

Request:

- High energy tomography for medical and paleontology applications
- 100 x 20 mm² field
- 30 **150+** keV energy range

Possible reuse of custom F300 mm lens New mechanical design



Current system: FReLoN CCD/fiberoptic taper
Rapid taper burnish in pink beam
Low absorption efficiency at high energy

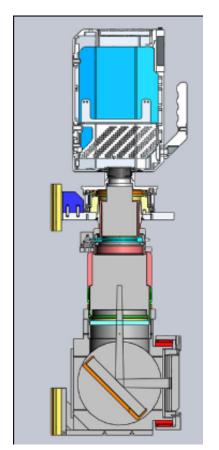
Geometrical distortions



Proposal: lens-based optical front-end



Layout





Pixel row alignment (FReLoN rotation)

Motorized iris

Motorized focusing

Lead glass protecting window

Lead shield housing

High absorption fiberoptic scintillator

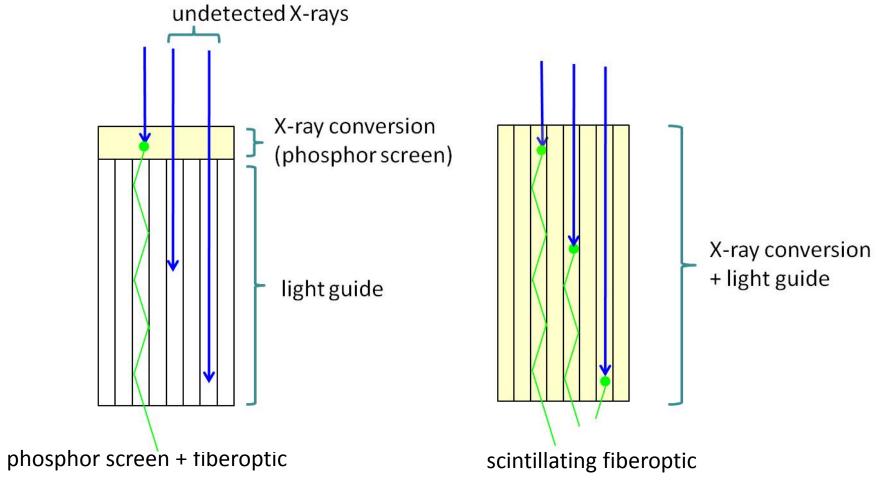
Pixel size	49 μm
FOV	100x20 mm ² up to 100x100 possible
QE @ 100 keV	> 99%
Frame rate	40 fps

Mechanical design: Christophe Jarnias (Det.Unit)



Applications: X-ray imaging, X-ray diffraction (> 30 keV)

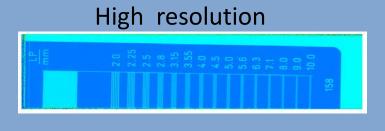
Scintillating fiberoptic plate

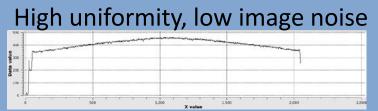




100 mm Large-field detector: First results (1)



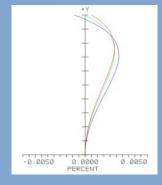




High efficiency at high energy 12.5 mm high-Z scintillator thickness

Low distortion





High image quality...

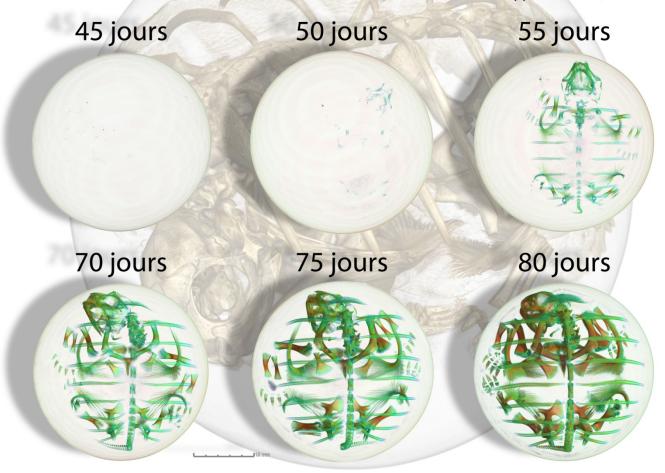


In-vivo crocodile embryo development Courtesy of P. Tafforeau, ID19

100 mm Large-field detector: First results (2)

Observation in ovo de la minéralisation du squelette chez Centrochelys sulcata

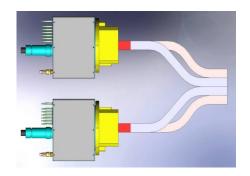
Paul Tafforeau (ESRF, Grenoble, France) et Martin Kundrát (Université d'Uppsala, Suède)





Future: 150mm Large field, LAFIP (PALEONTOLOGY)

- Large field fan taper optic to replace the FReLoN-2k taper optics
- Radiation hardness, better resolution, no mechanical shutter
- First proposal: 2-3 Frelon cameras with FAN (1:1)
- Second proposal: RayoniX camera with FAN (1:1)
- Third proposal: 2 Frelon cameras with FAN (1:1)
- Fourth proposal: High resolution camera with lens optical
 - Custom lens f=400mm
 - 24x36mm² chip size
 - Input size: 150mm width

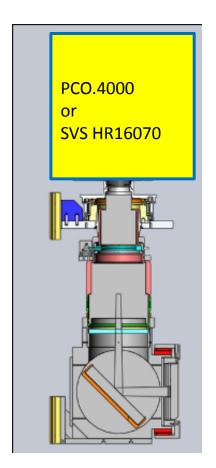








Specifications for CFT (lens) on-going



C. Ponchut, O. Hignette, T. Martin, H. Requardt, P. Tafforeau, A. Bravin

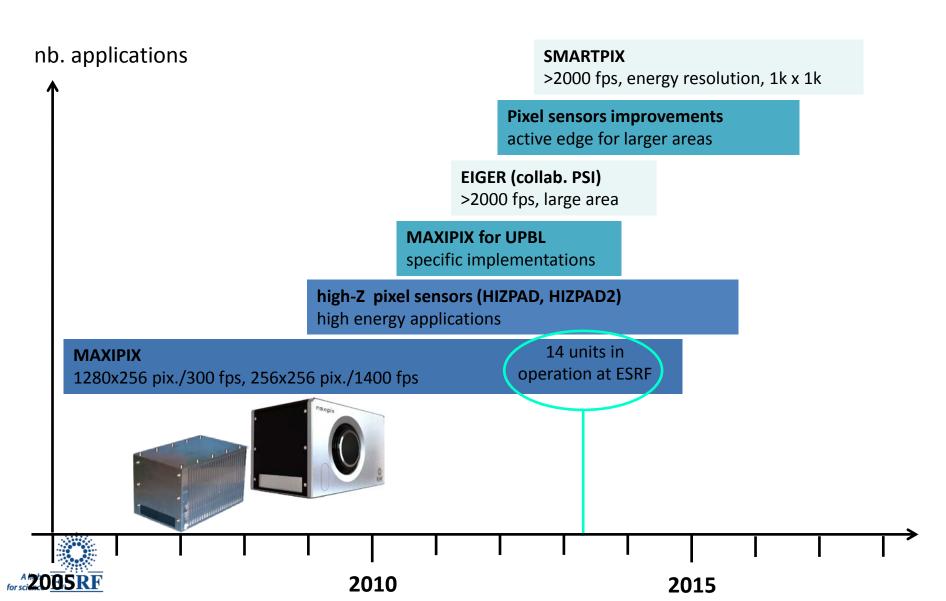
The MAXIPIX Detector and its evolution



TECHNOLOGY	CURRENT	FUTURE
SOFT X-RAYS		- Edgeless Si sensors
LARGE FIELD OF VIEW NEEDED	Si sensors TIMEPIX chip	- Medipix 3 & SMARTPIX
HARD X-rays		High-Z semiconductor sensors (HIZPAD ² project)



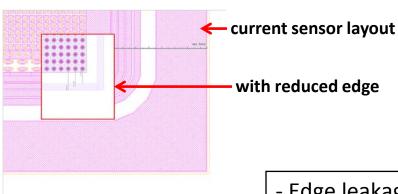
Development "roadmap"

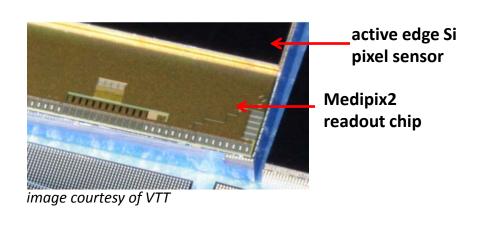


Si Edgeless detectors (1)

ESRF participation in multipartner project managed by VTT research centre of Finland (2012)

- Goal: side buttable sensors on 4 sides.
- => nearly seamless large areas can be built.





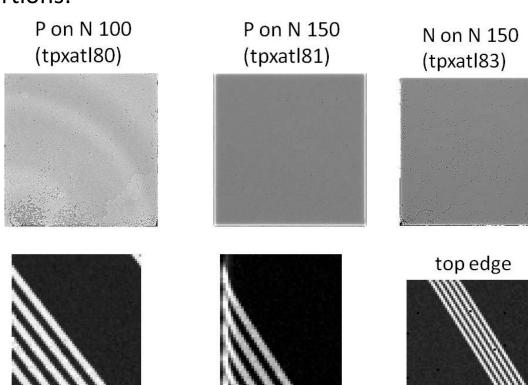
- Edge leakage current is controlled by sensor edge processing.
- Enables reduction or elimination of guard rings.

Ongoing: characterizations of active edge sensor samples at ESRF



Si Edgeless detectors (1)

Various doping schemes & gaps to physical edge Assemblies mounted on 2-side edgeless ESRF chipboards with Maxipix RO Flat-fields and edge distortions:



C. Ponchut, IWORID 2013

17.4 keV (Mo X-ray

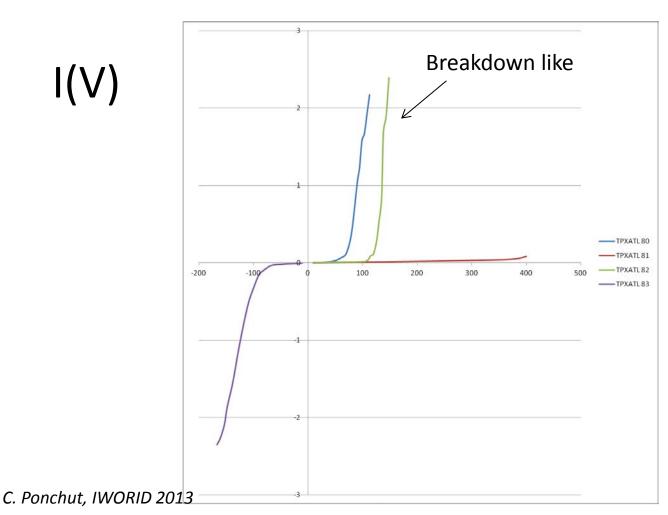
tube + Zr filter)



right edge

Si Edgeless detectors (2)





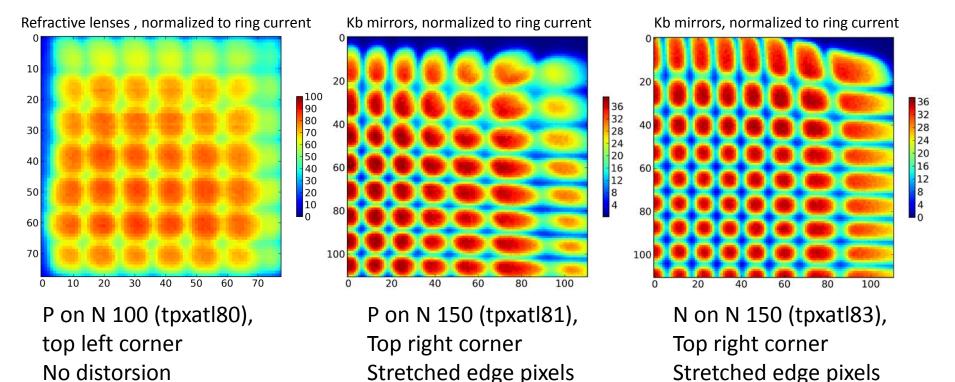
(P on N 500 um thick) (P on N 500 um thick) (P on N 500 um thick) (N on N 300 um thick)



Si Edgeless detectors (3)

MESH SCANS

BM05, 10 keV, threshold = 7 keV, 5 μ m steps 5x5 μ m theoretical beam spot size with refractive lenses; < 5 μ m with Kb mirrors.

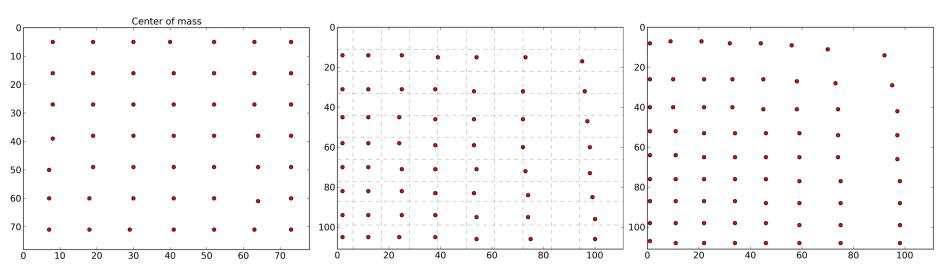




Si Edgeless detectors (4)

MESH SCANS

Corner pixels - measured centers of mass



P on N 100 (tpxatl80), top left corner No distorsion P on N 150 (tpxatl81), Top right corner Stretched edge pixels N on N 150 (tpxatl83), Top right corner Stretched edge pixels



Si Edgeless detectors (5)

First conclusions

- Compared polarities P on N (500 μm), N on N (300 μm)
- Compared edge structures 100, 150, G2-100
- Best edge behaviour : P on N type 100, but incomplete CCE
- Edge 100 seems better than edge 150 (less distortion)
- Correlation between low leakage current and higher edge distortions?
- Variability of image quality, leakage currents => process stability issue ?
- Active edge sensors with virtually no edge distortion can be produced.



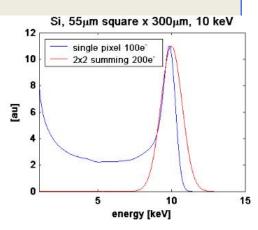
Medipix 3 and SMARTPIX Project

Integration of Medipix3:

Medipix3 chip = Medipix2 +

- Analog charge summing mode (charge sharing correction)
- Continuous read-write (no dead time)
- Configurable pixel counters 1,6,12,or 24 bits
- 1 to 8 thresholds/pixel
- Frame rates up to 6 kHz with 6 bit counters
- Compatible with 4-side stitching
- Same geometry as Medipix2 : 256x256, 55x55 μm² pixels

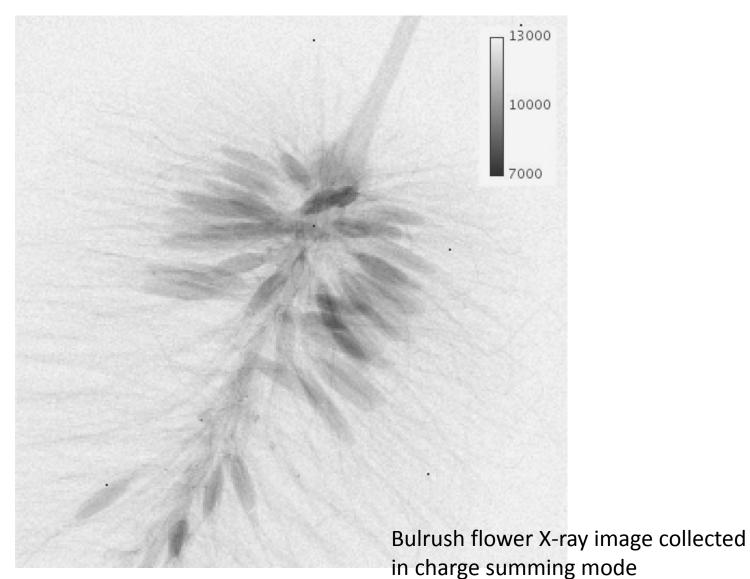
- Readout electronics (NIMAD) are under test
- Small modules to be characterized
- Long-term development for large area detectors
 - → SMARTPIX



Courtesy L. Tlustos, CERN



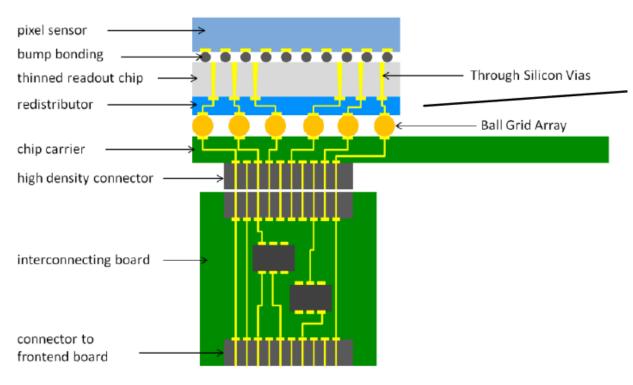
Medipix 3 and SMARTPIX Project





Medipix 3 and SMARTPIX Project

SMARTPIX is based on the use of Through silicon Vias (TSVs) for the Medipix 3 chip output



3D integration scheme and terminology



SMARTPIX

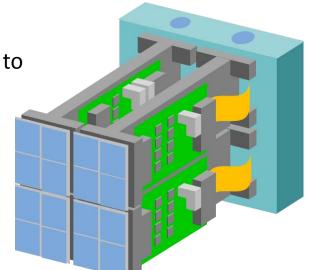
an implementation of Medipix3RX photon-counting chip for ESRF beamlines.

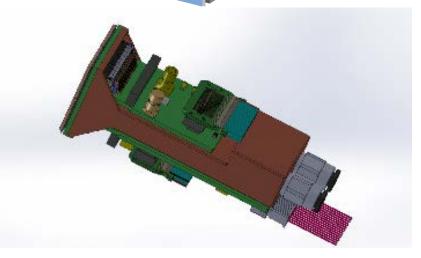
- Target specification :
- 60 x 60 mm² detection field (**1k x 1k pixels**), scalable to
- larger (or smaller) areas
- 30 x 30 mm² unit modules, dead gaps < 0.5 mm
- 55x55 μ m² pixel size
- 6000 fps frame rate
- No dead time (continuous read/write)
- 3 keV energy threshold
- Vacuum compatibility

Development challenges:

- Active edge sensors
- Vertical connections (TSV)

Fast readouts

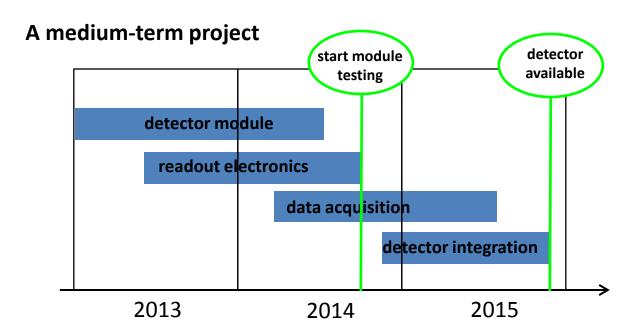




SMARTPIX benefits

SMARTPIX = evolution of **Maxipi** with:

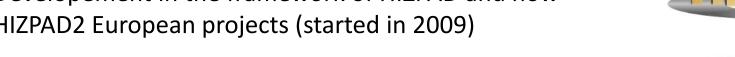
- higher frame rate
- larger areas possible
- enhanced energy resolution
- lower energy threshold



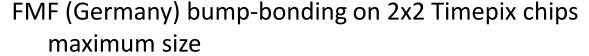


High Z sensor material : CdTe (1)

Developement in the framework of HIZPAD and now HIZPAD2 European projects (started in 2009)



CdTe sensor grown by Acrorad (Japan)



MAXIPIX ESRF readout system

Very simple design without cooling







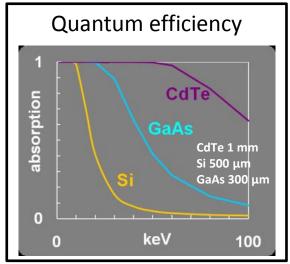


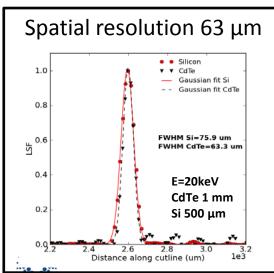




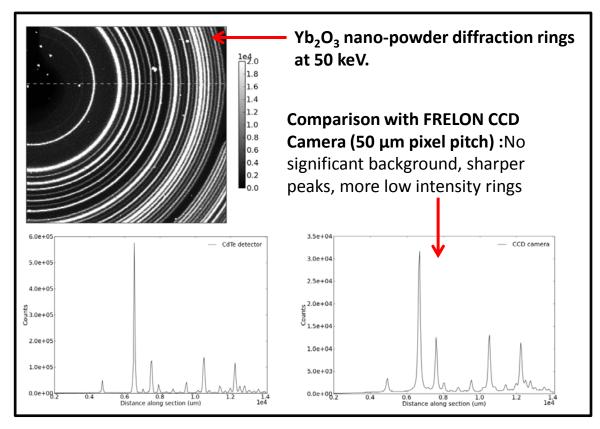


High Z sensor material: CdTe (2)





Linear count rate up to 10⁵ photons/pixel/s (Timepix limited)



GOOD PERFORMANCES!!

M. Ruat and C. Ponchut, *IEEE Trans. Nucl. Sci.*, Vol. 59, n° 5, pp. 2392-2401, August 2012 C. Ponchut and M. Ruat, *Proceedings of IWORID 2012*

M. Ruat, E. Gros d'Aillon and C. Ponchut, Proceedings of the 2012 IEEE NSS/MIC/RTSD conference

Beamline evaluations at ESRF

ID15 – Surface diffraction: Reflectivity liquid Ga on solid Sapphire at 70 keV (Oct. 2012)

ID15 – Surface diffraction: In-situ following of GaN growth at 70 keV (Oct. 2012)

ID11 – High resolution diffraction imaging at 80keV. Mechanical stability of retained austenite grains in TRIP steels studied by synchrotron X-ray diffraction during deformation (Nov. 2011)

ID17 - Edge-Illumination phase contrast imaging for mammography at 60 and 85 keV (Sept. 2012)

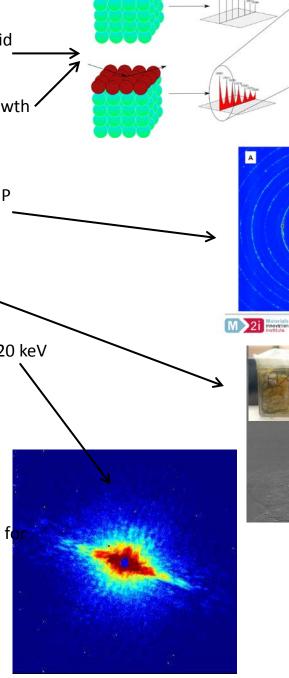
ID22 - Coherent SAXS or Ptychography experiment at 20 keV (Sept. 2012)

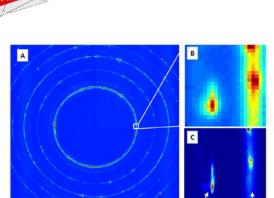
FUTURE:

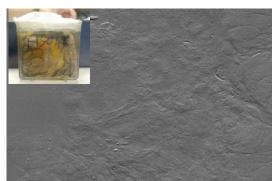
ID15 – Fast SAXS-WAXS experiment with Perkin Elmer detector for WAXS and Maxipix-CdTe for SAXS measurements

ID17 – Detector evaluation for new tomography setup for paleontology

ID17 – Dosimetry reconstruction for MRT







Austenite (111) | Ferrite (11

Current developments: Hybrid Pixel Detectors

High Z sensor material: CdTe (3)

GOOD PERFORMANCES....

BUT...

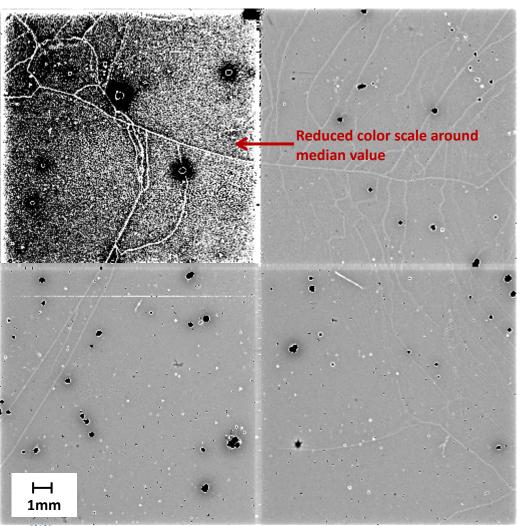
CdTe detectors suffer from native defects, defects induced by processing, and instabilities under irradiation

Examples to follow



Current developments: Hybrid Pixel Detectors

CdTe sensor : detector defects



Network of Lines (Native):

- -Increased counts by ~10%,
- Can be FF corrected
- Sub-grain boundaries
- Next to a line of reduced counts (drift of the charges to the neighbor pixels)

<u>Extended clusters of saturated</u> <u>pixels (from processing)</u>:

- current overflow of the analog input stage of the readout chip.
- Strain in the material (From E. Hamman *et al,* IEEE RTSD 2012)
- Surrounded by large areas of reduced counts (*gettering effect*)



CdTe sensorsDetector 'aging'

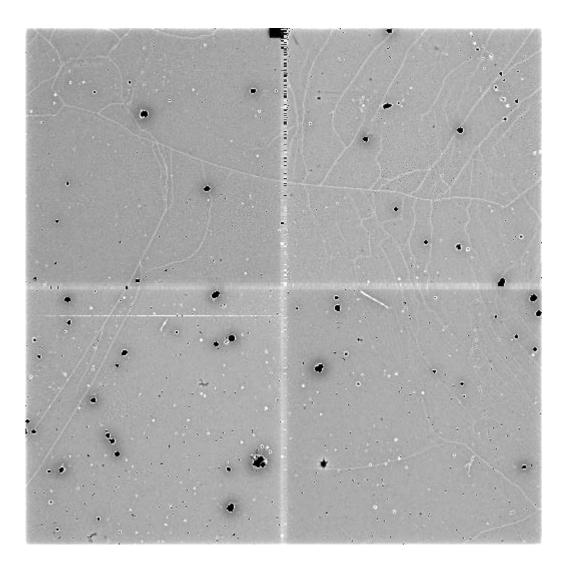


Flat-Field when received (2012-02)

Soleil synchrotron 20 keV + air scatterer

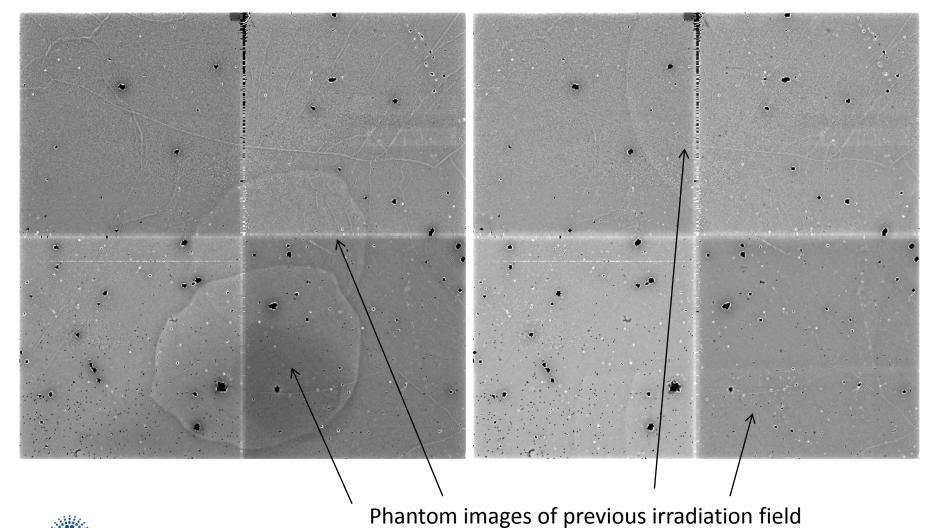
Thld 5

12 x 60 s





Temporary radiation damage (2013-03)



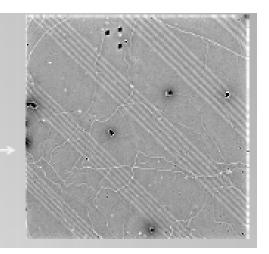


Temporary radiation damage (2013-05)

7.10⁵ photons/mm²/s with a lead pattern in front of the detector

Flat-field image after irradiation with pattern removed

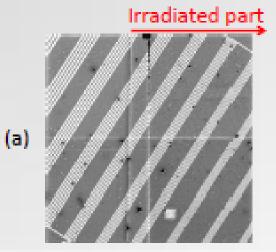
Temporary polarization = increased counts (similar to round shapes on central image)

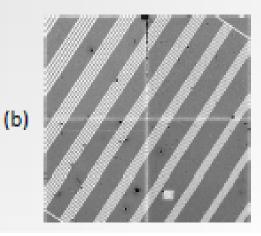


Reset bias voltage at regular intervals in time

Images of a lead pattern after continuous irradiation of one half of the detector surface with X-ray tube (Ag anode) at 10⁷ photons/mm²/s for 3h

- (a) without bias reset.
- (b) With bias reset every 10 min





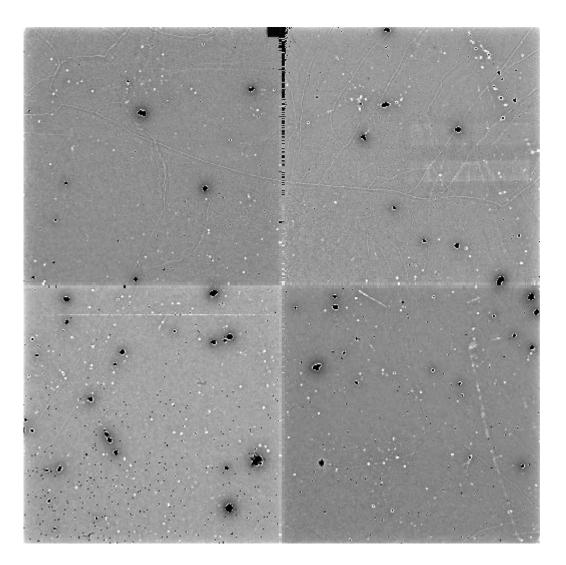


As is, after 18 months of experiments...

Ag Tube 35kVp – 25 mA + 100 um Ag filter

Thld 11

100 x 1 s





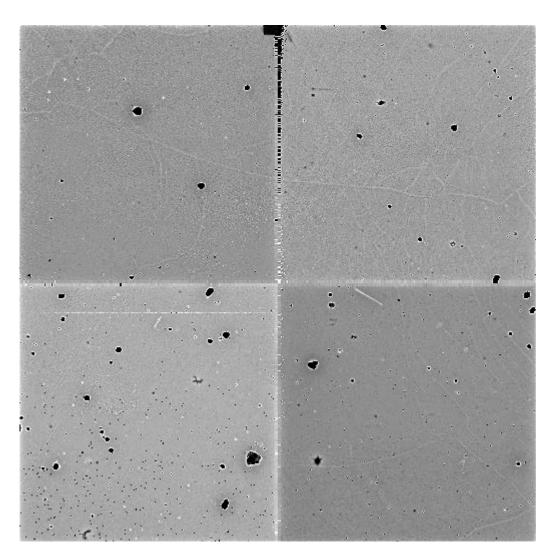
Chips 00, 01, 11 exhibit more extended defects + history effect. Chip 10 is noisy and some pixels look disconnected

After 2 hours at 50°C...

Ag Tube 35kVp – 25 mA + 100 um Ag filter

Thld 11

60 x 1 s





History effects have disappeared, as well as some defects on chips 00, 01, 11. Chip 10 idem → temporary :-(

Current developments: Hybrid Pixel Detectors

CdTe sensor: detector instabilities

- Extensive use \rightarrow quicker polarization, enhanced radiation damage, extra noise
- Low temperature baking (50°C) induces defects relaxation in CdTe

NEED TO CHARACTERIZE TEMPORARY vs PERMANENT or RECURRING EFFECTS And the way to avoid or 'anneal them', if possible.

 \rightarrow Need to improve the design by cooling and / or resetting the bias on the detector at regular interval times



Outline

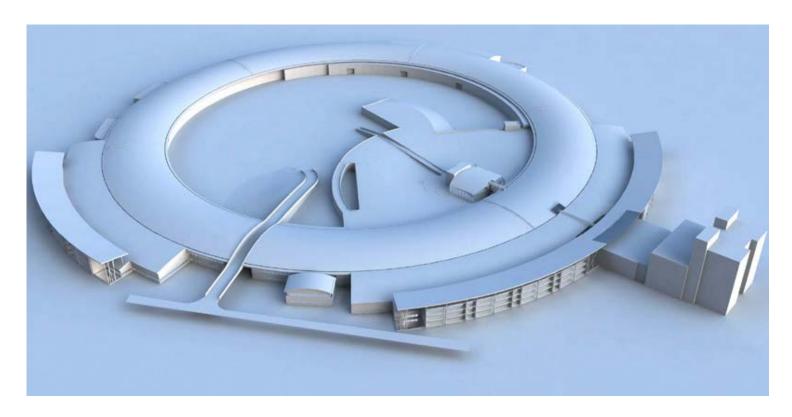
The Detector Unit at ESRF

Overview of current developments

Beamlines Upgrade program (UPBLs)



ESRF Upgrade



Longer beamlines, increased flux, new techniques → New detector solutions

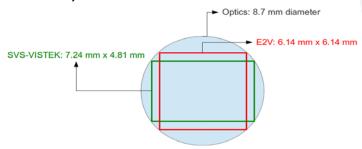


Phase I examples

NINA / NI

High resolution imaging and ptychography

- High resolution detector 16Mpixels
 - 10x custom optics (CFT)
 - 1.5um pixel size
 - Rot-C, 45° motorized mirror for 5x mag.
 - Frelon e2V 16Mp, 6.14 x 6.14 mm²
 - SVS HR16070, 7.24 x 4.81mm²

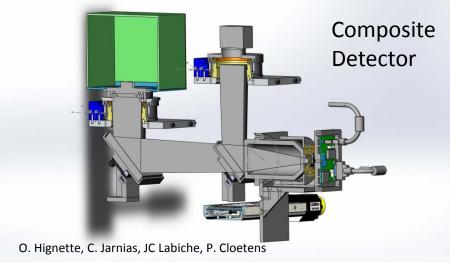


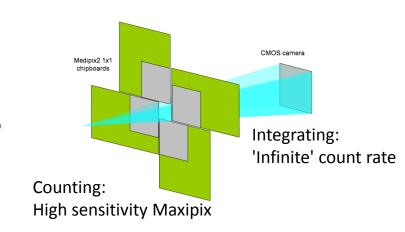


- Remote head Maxipix detector, 4 chips, 256x256
- Central hole ~5x5mm

Status:

detector delivery planned end 2013 (! optics)







NINA / NI

Energy dispersive detectors

Two identical detectors:

2 x PNdetector SDD 6 element arrays = 2 x 540mm² energy range ~2...25keV, global *throughput* count rate to ~6Mcps

Fast MCA spectra readout to 1kHz, based on existing (ID22) XIA-XMAP pulse processors

8 (1.5:1)

8 (1.5:1)

9 (1.5:1)

9 (1.5:1)

9 (1.5:1)

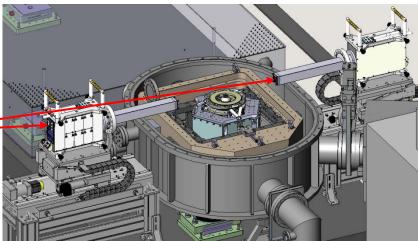
9 (1.5:1)

9 (1.5:1)

detectors assembled by SGX Sensortech

Operation in vacuum ~10⁻⁷mbar, confined space need for ~30mm approach to sample for large detection solid angle.

Detector Peltier coolers and electronics are water cooled.



detectors show in retracted position

F Villar 20130319

J. Morse, P. Cloetens, R. Tucoulou, G. Martinez Criado, E. Gagliardini, F. Villar, C. Cohen

- detectors delivery planned for June 2013
- upgrade of obsolescent ID22 DAQ (PXI-->PXIe), testing by BCU and C Cohen completed.

Status:

NINA / NA

Energy dispersive detectors

Operation in air

'Low energy'

Two identical detectors:

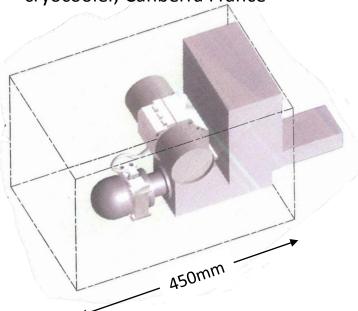
~2...25keV, total throughput count rate to ~3Mcps

2 x PNdetector silicon drift-diode 3 element arrays = 2 x

270mm², detectors assembled by SGX Sensortech

25.50 25.50 20.00 10 'High energy' single detector:

~2...70keV, throughput count rate to ~4Mcps 8 element germanium diode array = 400mm² low vibration, water cooled Pulse Tube cryocooler, Canberra France



Status: CFT completed, finalizing contract, delivery ~April 2014

Status:



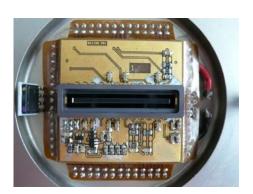
detector delivery planned for Sept 2013

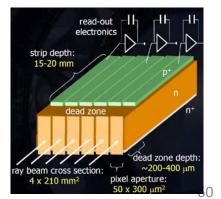
J. Morse, P. Cloetens, R. Tucoulou, G. Martinez Criado, E. Gagliardini, F. Villar, C. Cohen

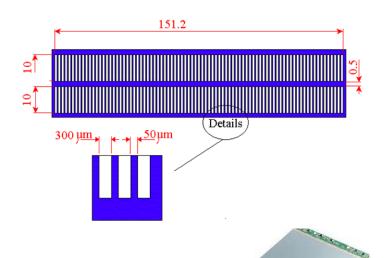
ID17

In-line Germanium detector, 350µm pitch

- Spare and obsolescence issues of electronics
- Request also
 - better resolution (50μm)
 - why not 2D (151mm x10mm)
 - 10µs readout time
 - Investigations are on-going
 - Ge upgrade
 - Microstrip sensors i.e. Elettra Picasso (Si microstrip sensors illuminated in the edge)
 - Flat panel
 - Pixel detectors
 - Frelon Hama + Front-end optics



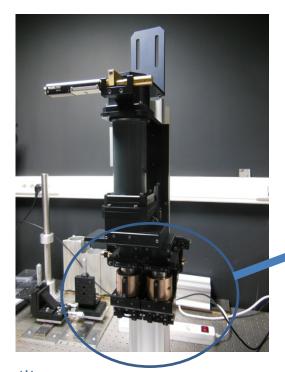


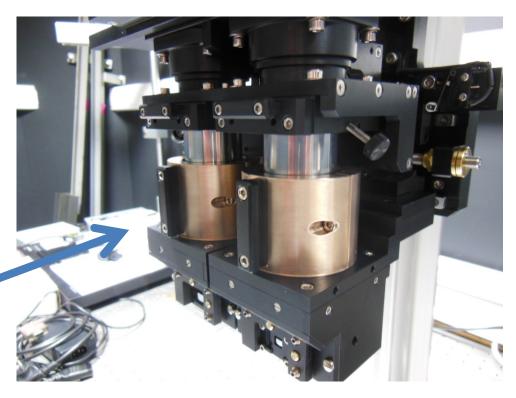




ID19: High resolution detector for white beam application

- Folded head (mirror between scintillator and objective)
- Rot-C (F-mount and Frelon)
- Two motorized optics
- 5x, 10x magnification, Mitutoyo objectives
- Eyepiece for large format sensor



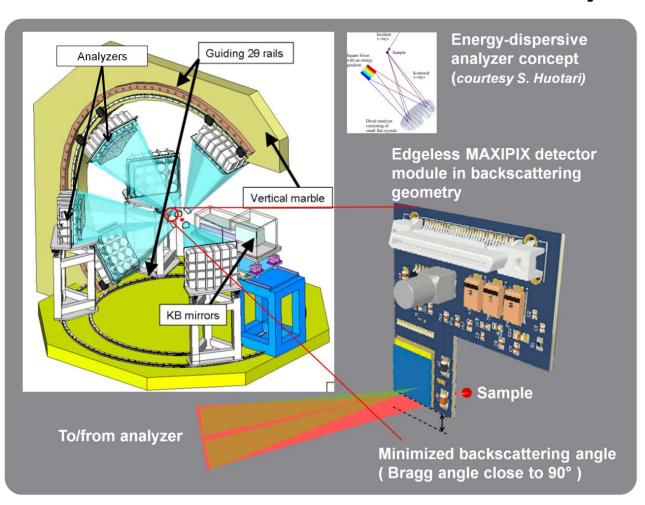


Optique Peter, A. Rack, P. Tafforeau, E. Boller



Status:

UPBL6 –ID20 Raman spectrometer



1 single chip **MAXIPIX** detector per analyzer (end May 2013)

Specific chipboard with no edges along one corner enables :

- minimum back scattering angle
- tilted geometries

C. Ponchut, J.M. Rigal, C. Jarnias, D. Pothin, G. Monaco, M. Krish



Status:

detector commissioned July 2013

Many thanks to the following people who contributed to this presentation:

The ESRF Detector Unit

Collaborators of Beamline Control Unit see presentation by A. Homs @ 16:10

Collaborators of Electronics Unit and Engineering group

Collaborators of the ESRF Science Division

Our partners from collaborative projects

Thank you for your attention!

